## Applicant(s)/Patent Under Application/Control No. Reexamination 10/075,283 IWAYAMA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Neveen Abel-Jalil 2165 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 10-1998 Spencer, Graham 707/5 US-5,826,261 Α В US-US-С US-D US-Ε US-F US-G US-Н US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν O Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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